



<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10820365</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>WANG ET AL.</p>
	<p>Examiner</p> <p>Rossoshek, Helen</p>	<p>Art Unit</p> <p>2825</p>

Class	Sub Class	Date	Examiner
716	1, 5,8,19	4/25/2006	HR
703	2	4/25/2006	HR
257	531	4/25/2006	HR

U.S. Patent and Trademark Office	Part of Paper No.: 04242006
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<b>Search Notes</b>  	Application/Control No.  10820365	Applicant(s)/Patent Under Reexamination  WANG ET AL.
	Examiner Rossoshek, Helen	Art Unit 2825

Notes	Date	Examiner
EAST - USPAT; US-PGPUB; EPO: JPO: DERWENT; IBM_TDB	4/24/2006	HR
IEEE	4/24/2006	HR

U.S. Patent and Trademark Office	Part of Paper No.: 04242006
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